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- D-Type Flip-Flops in a Single Package With 3-State Bus Driving True Outputs
- **Full Parallel Access for Loading**
- **Buffered Control Inputs**
- **Package Options Include Plastic** Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

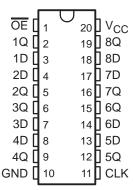
#### description

These octal D-type edge-triggered flip-flops feature 3-state outputs designed specifically for drivina highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

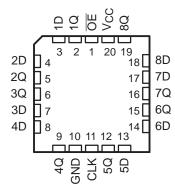
On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

A buffered output-enable  $(\overline{OE})$  input places the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines without interface or pullup components.

SN54ALS374A, SN54AS374 . . . J PACKAGE SN74ALS374A, SN74AS374 . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS374A, SN54AS374 . . . FK PACKAGE (TOP VIEW)



OE does not affect internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54ALS374A and SN54AS374 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS374A and SN74AS374 are characterized for operation from 0°C to 70°C.

#### **FUNCTION TABLE** (each flip-flop)

	INPUTS	OUTPUT	
OE	CLK	D	Q
L	$\uparrow$	Н	Н
L	$\uparrow$	L	L
L	H or L	Χ	$Q_0$
Н	X	Χ	Z

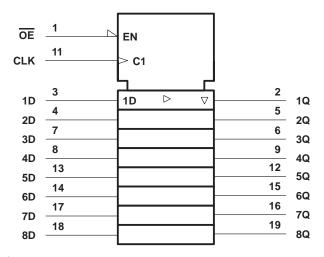


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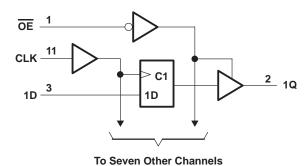


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## logic symbol<sup>†</sup>



## logic diagram (positive logic)



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V <sub>CC</sub>	0.5	V to 7 V
Input voltage range, V <sub>I</sub>	0.5	V to 7 V
Voltage applied to a disabled 3-state output	. −0.5 ∨	/ to 5.5 V
Package thermal impedance, θ <sub>JA</sub> (see Note 1): DW package		58°C/W
N package		69°C/W
Storage temperature range, T <sub>stg</sub>	–65°C	to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

## recommended operating conditions

		SN54ALS374A		'4A	SN7	'4A	UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
Іон	High-level output current			-1			-2.6	mA
loL	Low-level output current			12			24	mA
T <sub>A</sub>	Operating free-air temperature	-55		125	0		70	°C

<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		SN5	4ALS374	1A	SN7	LINUT		
PARAMETER	1531 00	TEST CONDITIONS		TYP <sup>†</sup>	MAX	MIN	TYP <sup>†</sup>	MAX	UNIT
VIK	$V_{CC} = 4.5 \text{ V},$	I <sub>I</sub> = -18 mA			-1.5			-1.5	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2			V <sub>CC</sub> -2			
Voн	V 4 5 V	$I_{OH} = -1 \text{ mA}$	2.4	3.3					V
	V <sub>CC</sub> = 4.5 V	$I_{OH} = -2.6 \text{ mA}$				2.4	3.2		
Voi	V00 - 45 V	I <sub>OL</sub> = 12 mA		0.25	0.4		0.25	0.4	V
VOL	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 24 mA					0.35	0.5	V
lozh	$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 2.7 V			20			20	μΑ
l <sub>OZL</sub>	$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 0.4 V			-20			-20	μΑ
lį	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 7 V			0.1			0.1	mA
lН	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 2.7 V			20			20	μΑ
I <sub>Ι</sub> Γ	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V			-0.2			-0.2	mA
I <sub>O</sub> ‡	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
		Outputs high		11	20		11	19	
ICC	V <sub>CC</sub> = 5.5 V	Outputs low		19	28		19	28	mA
		Outputs disabled		20	31		20	31	

## timing requirements over recommended operating free-air temperature range (unless otherwise noted)

		SI		SN54ALS374A		SN74ALS374A	
			MIN	MAX	MIN	MAX	UNIT
fclock	Clock frequency			30		35	MHz
t <sub>W</sub>	Pulse duration	CLK high or low	16.5		14		ns
t <sub>su</sub>	Setup time	Data before CLK↑	10		10		ns
th	Hold time	Data after CLK↑	4		0		ns

## switching characteristics over recommended operating conditions (unless otherwise noted (see Figure 3)

PARAMETER	FROM	то	SN54ALS374A		SN74AL	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT
fmax			30		35		MHz
t <sub>PLH</sub>	CLK		3	14	3	12	ne
t <sub>PHL</sub>	CLK	Q	5	17	5	16	ns
<sup>t</sup> PZH	<del></del>		3	18	3	17	ne
t <sub>PZL</sub>	ŌĒ	Q	5	21	5	18	ns
<sup>t</sup> PHZ	ŌĒ	Q	1	11	1	10	20
t <sub>PLZ</sub>	OE .	Q .	2	19	2	18	ns



<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

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## recommended operating conditions

		SN54AS374			SI	<b>'</b> 4	UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.7			0.8	V
ІОН	High-level output current			-12			-15	mA
loL	Low-level output current			32			48	mA
TA	Operating free-air temperature	-55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CO	MOITIONS	SN	154AS374	4	SN	UNIT		
PARAMETER	1231 00	TEST CONDITIONS		TYP†	MAX	MIN	TYP†	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V <sub>CC</sub> -2			V <sub>CC</sub> -2			
VOH	Voc = 45 V	$I_{OH} = -12 \text{ mA}$ 2.4 3.2				V			
	V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -15 mA				2.4	3.3		
V	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 32 mA		0.29	0.5				V
V <sub>OL</sub>		I <sub>OL</sub> = 48 mA					0.34	0.5	V
lozh	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.7 V			50			50	μА
lozL	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.4 V			-50			-50	μА
IĮ	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA
lіН	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 2.7 V			20			20	μА
OE, CLK	V 55V	V- 0.4.V			-0.5			-0.5	A
l <sub>IL</sub> Data	V <sub>CC</sub> = 5.5 V,	$V_1 = 0.4 V$			-3			-2	mA
IO <sup>‡</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30		-112	-30		-112	mA
		Outputs high		77	120		77	120	
Icc	V <sub>CC</sub> = 5.5 V	Outputs low		84	128		84	128	mA
		Outputs disabled		84	128		84	128	

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

#### timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			SN54A	S374	SN74A	UNIT	
			MIN	MAX	MIN	MAX	UNIT
fclock	Clock frequency			100*		125	MHz
	Pulse duration	CLK high	5.5*		4		20
t <sub>W</sub>	ruise duration	CLK low	3*		3		ns
t <sub>su</sub>	Setup time	Data before CLK↑	3*		2		ns
t <sub>h</sub>	Hold time	Data after CLK↑	3*		2		ns

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.



<sup>‡</sup> The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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# switching characteristics over recommended operating conditions (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	то	SN54AS374		SN74A	UNIT	
FARAWETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT
fmax			100*		125		MHz
tPLH	CLK	_	3	11	3	8	no
t <sub>PHL</sub>	CLK	Q	4	11.5	4	9	ns
<sup>t</sup> PZH	ŌĒ		2	7	2	6	ne
t <sub>PZL</sub>	OE .	Q	3	11	3	10	ns
<sup>t</sup> PHZ	ŌĒ	Q	2	10	2	6	ns
t <sub>PLZ</sub>	OE OE	Q	2	7	2	6	115

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

#### **APPLICATION INFORMATION**

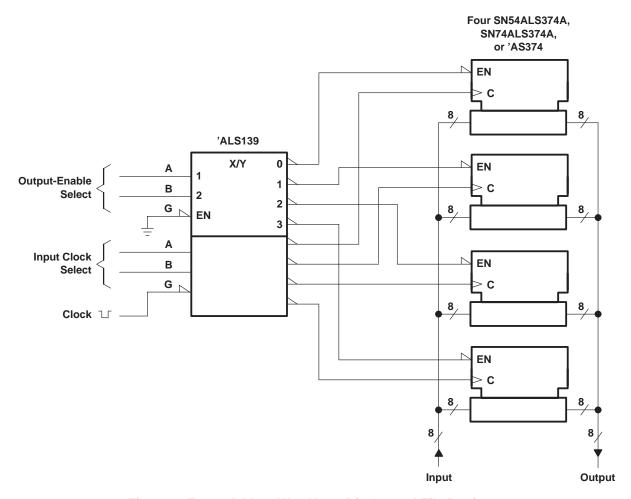


Figure 1. Expandable 4-Word by 8-Bit General File Register



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#### **APPLICATION INFORMATION**

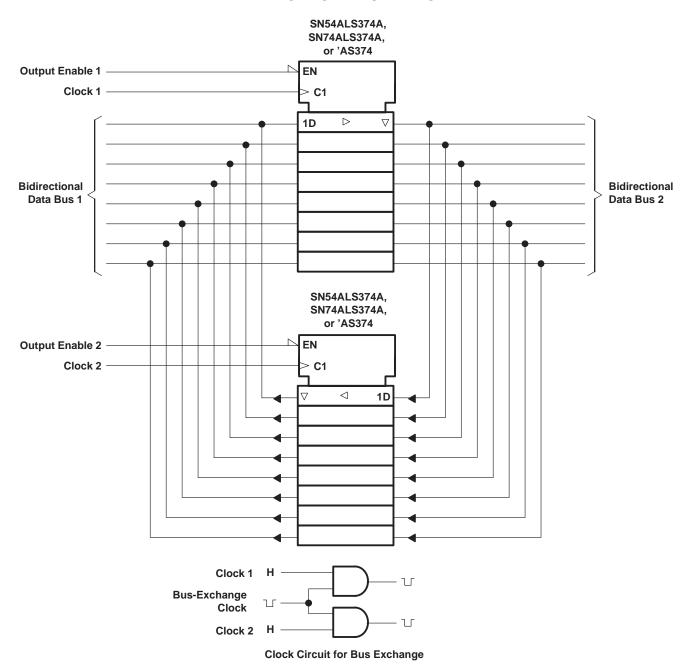
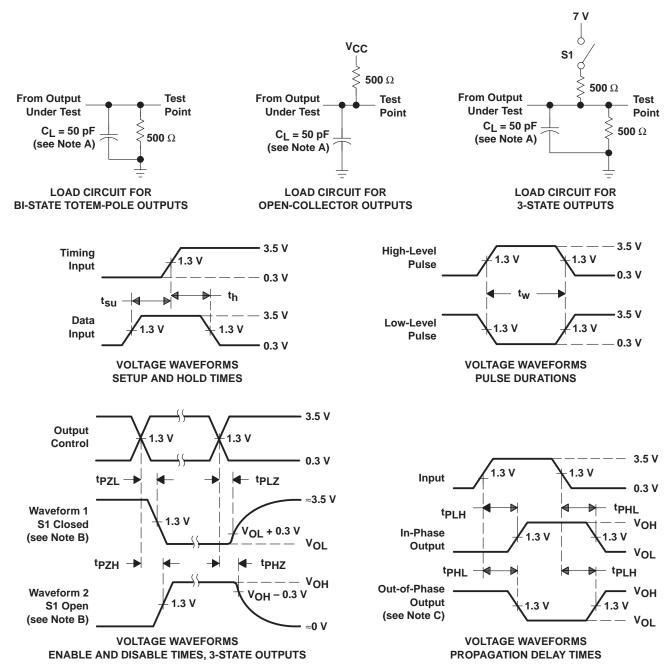


Figure 2. Bidirectional Bus Driver

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## PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_{\Gamma} = t_{f} = 2$  ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 3. Load Circuits and Voltage Waveforms



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